




<b>Search Notes</b>  	Application/Control No.  10026538	Applicant(s)/Patent Under Reexamination  KIM ET AL.
	Examiner Nguyen-Ba, Hoang-Vu A	Art Unit 2192

Notes	Date	Examiner
719/330, 310, 313, 315, 316; 707/100, 102, 103R, 103Y, 103X, 103Z, 205, 10 -- text search only	06/20/2006	HAN
Non Patent Literature Search -- IP.com	06/20/2006	HAN
Interference Search -- see search history printout	06/20/2006	HAN
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<b>Interference Searched</b>  	Application/Control No.  10026538	Applicant(s)/Patent Under Reexamination  KIM ET AL.
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Class	SubClass	Date	Examiner
719	330,	06/20/2006	HAN
707	103R, 10	6/20/06	HAN

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<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10026538</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>KIM ET AL.</p>
	<p>Examiner</p> <p>Nguyen-Ba, Hoang-Vu A</p>	<p>Art Unit</p> <p>2192</p>

Class	SubClass	Date	Examiner
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